TOSHIBA Photocoupler IRED & Photo-IC

TLP2200

Isolated Bus Driver
High Speed Line Receiver
Microprocessor System Interfaces
MOS FET Gate Driver
Direct Replacement for HCPL-2200

The TOSHIBA TLP2200 consists of an infrared emitting diode and integrated high gain, high speed photodetector. This unit is 8–lead DIP package.

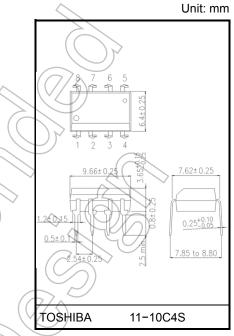
The detector has a three state output stage that eliminates the need for pull–up resistor, and built–in Schmitt trigger. The detector IC has an internal shield that provides a guaranteed common mode transient immunity of $1000V\,/\,\mu s$.

- Input current: IF = 1.6 mA
- Power supply voltage: V_{CC} = 4.5 to 20 V
- Switching speed: 2.5MBd guaranteed
- Common mode transient immunity: ±1000V / µs (min)
- Guaranteed performance over temperature: 0 to 85°C
- Isolation voltage: 2500 Vrms (min)
- UL-recognized: UL 1577, File No.E67349
- cUL-recognized: CSA Component Acceptance Service No.5A

File No.E67349

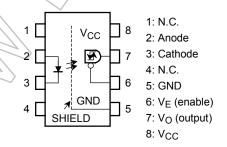
Truth Table (positive logic)

| Input | Enable | Output |
|-------|--------|--------|
| Н | (H, /, | Z |
| L | H | Z |
| Н | L | Н |
| L | \ | L |

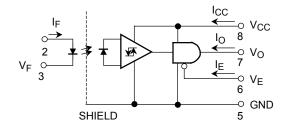


Weight: 0.54 g (typ.)

Pin Configuration (top view)



Schematic



Start of commercial production 1986-07



Recommended Operating Conditions

| Characteristic | Symbol | Min | Тур. | Max | Unit |
|-----------------------|---------|-----|------|-----|------|
| Input current, on | IF(ON) | 1.6 | 1 | 5 | mA |
| Input current, off | IF(OFF) | 0 | 1 | 0.1 | mA |
| Supply voltage | Vcc | 4.5 | 1 | 20 | V |
| Enable voltage high | VEH | 2.0 | 1 | 20 | V |
| Enable voltage low | VEL | 0 | _ | 0.8 | V |
| Fan out (TTL load) | N | _ | _ | 4 | |
| Operating temperature | Topr | 0 | _ | 85 | °C (|

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Absolute Maximum Ratings (no derating required up to 70°C)

| | Characteristic | Symbol | Rating | Unit |
|--------|--|----------------------|---------------|-------|
| | Forward current | lf 🏑 (| 10 | mA (|
| | Peak transient forward current (Note 1) | IFPT | 1 | A |
| ш | Reverse voltage | VR | 5 | (4// |
| _ | Input Power Dissipation | PD | 45 | mW |
| | Input power dissipation derating (Ta ≥ 70°C) | ΔΡ ₀ /ΔΤα | -0.86 | mW/°C |
| | Output current | lo | 25 | mΑ |
| _ _ | Supply voltage | Vcc | −0.5 to 20 | V |
| c t | Output voltage | Vo | -0.5 to 20 | V |
| Ф | Three state enable voltage | VE | -0.5 to 20 | V |
| e t | Output Power Dissipation | Po | 100 | mW |
| | Output Power Dissipation Derating (Ta ≥ 70°C) | ΔP ₀ /°C/ | -1.9 | mW/°C |
| | Total package power dissipation (Note 2) | PT | <i>J)</i> 210 | mW |
| Оре | rating temperature range | Topr | −40 to 85 | °C |
| Stor | age temperature range | T _{stg} | −55 to 125 | °C |
| Lead | d solder temperature (10 s) (**) | T _{sol} | 260 | °C |
| | ation voltage 60 s, R.H. ≤ 60 %,Ta = 25°C) (Note 3) | BVS | 2500 | Vrms |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- (Note 1) Pulse width 1 μ s, 300 pps.
- (Note 2) Derate 4.5 mW / °C above 70 °C ambient temperature.
- (Note 3) Device considered a two terminal device: Pins 1, 2, 3 and 4 shorted together, and pins 5,6,7 and 8 shorted together
 - (**) 1.6 mm below seating plane.

Electrical Characteristics (unless otherwise specified, Ta = 0 to 85 °C, Vcc = 4.5 to 20 V, IF(ON) = 1.6 to 5 mA, IF(OFF) = 0 to 0.1 mA, VEL = 0 to 0.8 V, VEH = 2.0 to 20 V)

| Characteristic | Symbol | Test Condition | | Min | Typ.* | Max | Unit |
|--|-----------------------|---|--------------------------------|--------------------|------------------|-------|---------|
| Output leakage current | _ | I _F = 5 mA, | V _O = 5.5 V | _ | | 100 | _ |
| (Vo > Vcc) | Іонн | V _{CC} = 4.5 V | V _O = 20 V | - (| 2 | 500 | μΑ |
| Logic low output voltage | V _{OL} | I _{OL} = 6.4 mA (4 TT | L load) | | 0.32 | 0.5 | V |
| Logic high output voltage | Voн | I _{OH} = -2.6 mA | \wedge | 2.4// | 3.4 | _ | V |
| Logic low enable current | I _{EL} | V _E = 0.4 V | | | -0.13 | -0.32 | mA |
| | | V _E = 2.7 V | | 7 | 1 | 20 | |
| Logic high enable current | IEH | VE = 5.5 V | | | - / | 100 | μΑ |
| | | V _E = 20 V | 4 | > _ | 0.01 | 250 | |
| Logic low enable voltage | VEL | - | | 1 | | 0.8 | V |
| Logic high enable voltage | VEH | - | - (\lambda \lambda \rangle) | 2.0 | (\bigcirc) | | V |
| Logia law auggly auggent | la a | I _F = 0 mA | V _{CC} = 5.5 V | _ | 5 | 6.0 | mA |
| Logic low supply current | ICCL | VE = don't care | Vcc = 20 V | +0 | 5.6 | 7.5 | |
| Logic high supply current | Іссн | IF = 5 mA VE = don't care | V _{CC} = 5.5 V | | 2.5 | 4.5 | mA |
| | | | V _{CC} = 20 V | (775) | 2.8 | 6.0 | |
| | lozL | IF = 5 mA VE = 2 V | V _O = 0.4 V | | 1 | -20 | |
| High impedance state | | I _F = 0 mA V _E = 2 V | V _O = 2.4 V |) — | _ | 20 | μΑ |
| output current | | | V _O = 5.5 V | / – | - | 100 | |
| | | , | V _O = 20 V | _ | 0.01 | 500 | |
| Logic low short circuit | last | IF ≠ 0 mA | $V_0 = V_{CC} = 5.5 \text{ V}$ | 25 | 55 | _ | mA |
| output current (Note 4) | losL | TIF F O TITA | $V_0 = V_{CC} = 20 \text{ V}$ | 40 | 80 | _ | ША |
| Logic high short circuit | | IF = 5 mA | V _{CC} = 5.5 V | -10 | -25 | _ | mA |
| output current (Note 4) | Iosh | Vo = GND | V _{CC} = 20 V | -25 | -60 | _ | ША |
| Input current hysteresis | IHYS | V _{CC} = 5 V | | 1 | 0.05 | _ | mA |
| Input forward voltage | ⟩ V _F | I _F = 5 mA, Ta = 25 °C | | _ | 1.55 | 1.7 | V |
| Temperature coefficient of forward voltage | ΔV _F / ΔTa | I _F = 5 mA | | _ | -2.0 | _ | mV / °C |
| Input reverse breakdown voltage | BVR | I _R = 10 μA, Ta = 25 °C | | 5 | _ | _ | V |
| Input capacitance | Cin | V _F = 0 V, f = 1 MHz, Ta = 25 °C | | _ | 45 | _ | pF |
| Resistance (input-output) | RI-O | V _{I-O} = 500 V R.H. ≤ 60 % (Note 3) | | 5×10 ¹⁰ | 10 ¹⁴ | _ | Ω |
| Capacitance (input-output) | C _I -O | V _{I-O} = 0 V, f = 1 M | _ | 0.6 | _ | pF | |

^(**) All typ. values are at Ta = 25 °C, VCC = 5 V, IF(ON) = 3 mA unless otherwise specified.

Switching Characteristics

(unless otherwise specified, Ta = 0 to 85 °C,Vcc = 4.5 to 20 V,IF(ON) = 1.6 to 5 mA, IF(OFF) = 0 to 0.1 mA)

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|--|------------------|-----------------|--|-------|---------------|----------|--------|
| Propagation delay time to logic high output level | t _{pLH} | | Without peaking capacitor C1 | | 235 | | ns |
| (Not | te 5) | | With peaking capacitor C ₁ | (-) | <i>></i> − | 400 | |
| Propagation delay time to logic low output level | t _{pHL} | 1 | Without peaking capacitor C ₁ | | 250 | ı | ns |
| (Not | te 5) | | With peaking capacitor C ₁ |)+ | _ | 400 | |
| Output rise time (10-90%) | t _r | | | /_ | 35 | - | ns |
| Output fall time (90-10%) | t _f | | - (()> | _ | 20 | - | ns |
| Common mode transient immunity at logic high output (Not | CM _H | 3 | I _F = 1.6 mA, V _{CM} = 50 V, Ta = 25 °C | -1000 | | <u> </u> | V / μs |
| Common mode transient immunity at logic low output (Not | CM _L | 3 | I _F = 0 mA, V _{OM} = 50 V, Ta = 25 °C | 1000 | | · _ | V / μs |

(*) All typ. values are at Ta = 25 °C, VCC = 5 V, IF(ON) = 3 mA unless otherwise specified

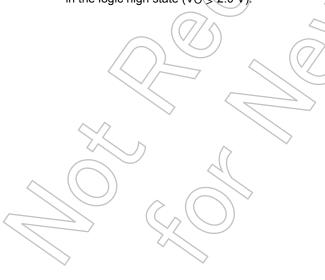
(Note 4) Duration of output short circuit time should not exceed 10ms.

(Note 5) The t_{pLH} propagation delay is measured from the 50 % point on the leading edge of the input pulse to the 1.3 V point on the leading edge of the output pulse.

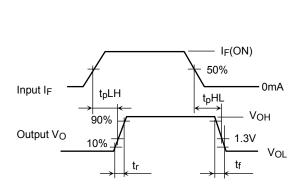
The t_{pHL} propagation delay is measured from the 50 % point on the trailing edge of the input pulse to the 1.3 V point on the trailing edge of the output pulse.

(Note 6) CML is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_O < 0.8 \text{ V}$).

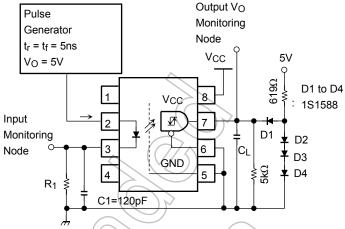
CMH is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic high state (VO > 2.0 V).



Test Circuit 1 tpHL, tpLH, tr and tf



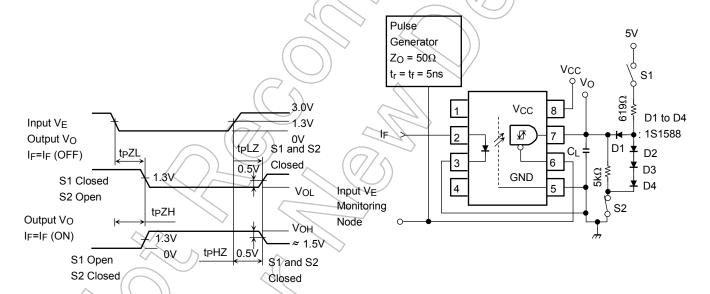
| R ₁ | 2.15kΩ | 1.1kΩ | 681Ω | |
|---------------------|--------|-------|------|--|
| I _F (ON) | 1.6mA | 3mA | 5mA | |



C₁ is peaking capacitor. The probe and jig capacitances are included in C₁.

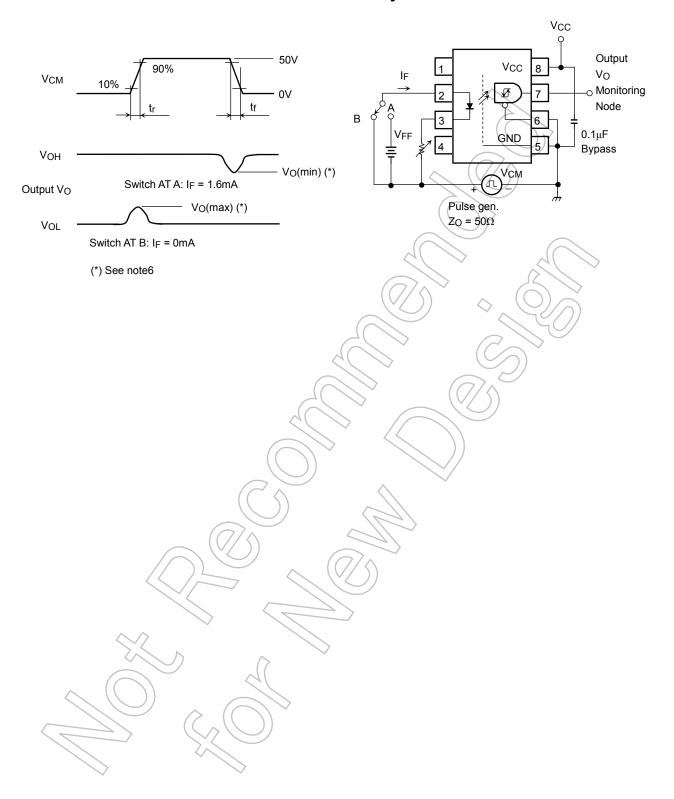
C_L is approximately 15pF which includes probe and stray wiring capacitance.

Test Circuit 2 tpHz, tpZH, tpLz and tpZL



C_L is approximately 15pF which includes probe and stray wiring capacitance.

Test Circuit 3 Common Mode Transient Immunity



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